

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10812075	SEKIGUCHI ET AL.
Examiner	Art Unit	
	Jaisle, Cecilia M	1624

SEARCHED			
Class	Subclass	Date	Examiner
514	275	6/24/2007	Cecilia Jaisle
544	332, 330	6/25/2007	Cecilia Jaisle
544	310, 312	7/9/2007	Cecilia Jaisle
514	275, 235.8	10/29/2007	Cecilia Jaisle
544	310, 312, 122, 123	10/29/2007	Cecilia Jaisle
514	235.8, 275	4/28/2008	C. Jaisle
544	310, 312, 122, 123	4/28/2008	C. Jaisle
514	235.8, 275	9/18/2008	C. Jaisle
544	310, 312, 122, 123	9/18/2008	C. Jaisle

SEARCH NOTES			
Search Notes	Date	Examiner	
STN search and Inventor Names searched by STIC	6/24/2007	Cecilia Jaisle	

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
514	275	10/29/2007	C. Jaisle
544	310, 312	10/29/2007	Cecilia Jaisle
514	235.8, 275	9/18/2008	C. Jaisle
544	301, 312, 122, 123	9/18/2008	C. Jaisle

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